Medical Grade Silicon Capacitor MGSC 0202 1nF BV30



Rev. 2.01

General description

The 1nF Medical Grade Silicon Capacitor targets filtering and decoupling in medical high reliability applications with significant space constraints.

Products have been tested specifically for medical applications and manufacturing is done in our Murata IATF 16949 certified facility.

A final specific electrical test is performed on 100% of our Medical grade capacitors.

1nF MGS Capacitor is using our PICS3-HV process which allows it to operate under 16V at 150°C

Key features

- Temperature stability (up to 150°C)
- Very low profile (100µm)
- Negligible capacitance loss through ageing
- Small size 0.63x0.63mm +/-20µm (0202)
- Low leakage current
- · High reliability

- Compatible with high temperature cycling during manufacturing operations (exceeding 300°C)
- Compatible with embedded process.

 Please refer to the specific Application Note
 "Embedded Silicon Capacitor"

Key applications

- Any demanding applications, such as industrial medical, implantable medical and healthcare Supply decoupling / filtering of active device
- Increase battery longevity



Functional diagram

The next figure provides implementation set-up diagram.

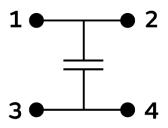


Figure 1 Block Diagram

Electrical performances

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
С	Capacitance value	@25°C	-	1	-	nF
$\Delta C_{\text{P}}^{(1)}$	Capacitance tolerance	@25°C	-15	-	+15	%
T _{OP}	Operating temperature		-55		+150	°C
T _{STG} ⁽²⁾	Storage temperature		10	-	+35	°C
ΔC_T	Capacitance temperature variation	-55°C to 150°C		76		ppm/K
RV _{DC} ⁽³⁾	Rated voltage		-	10	16 ⁽⁴⁾	V_{DC}
ΔC_{RVDC}	Capacitance voltage variation	From 0V to 10V @25°C	-	-	-0.02	%/V _{DC}
IR	Insulation resistor	@25°C,16V, 120s	-	<100	-	GΩ
ESR ⁽⁵⁾	Equivalent Serial Resistor	@+25°C, shunt mode, wirebonded on a board with SMA connectors	-	1.6	-	Ω
ESD	HBM stress ⁽⁶⁾	(100pF/1.5kOhms) max +/-8kV Level H3B	2	-	-	kV

Table 1 - 10nF MGS capacitor performances



^{(1):} other tolerance available upon request

^{(2):} without packaging. Please refer to the application note "MIS storage and shelf-life conditions"
(3): Lifetime is voltage and temperature dependent, please refer to application note 'Lifetime of 3D capacitors'
(4): 10 years of intrinsic life time prediction at 100°C continuous operation

^{(5):} Estimate

^{(6):} please refer to application note 'ESD Challenge in 3D Murata Integrated Passive technology'



Pinning definition

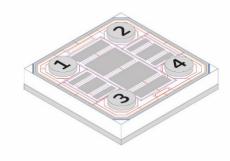


Figure 2 Pinning definition

pin #	Symbol	Coordinates X / Y
1	Signal	-147 / 147
2	Signal	147 / 147
3	Signal	-147 / -147
4	Signal	147 / -147

Table 2 - Pining description. Reference (0,0) located at the center of the die.

Parts should be glued with non-conductive paste. If conductive glue is used on the backside of the silicon capacitor, it's strongly recommended to avoid to connect the backside to electrical signal. If backside is connected to electrical signal, this signal will absolutely be the same as pads 3-4.

Ordering Information

Regardless of packaging, Murata Integrated Passive Devices delivers products with AQL level II (0.65).

Part number	Package				
(15NC)	Packaging	Finishing	Description		
935181730410 - T3A	T&R**	Al*	0202 -1nF – BV30 – T&R 1000pcs, Al pads		
935181730410 - W0A	Waffle Pack	Al*	0202 -1nF – BV30 – Waffle pack, Al pads		
935181730410 - T3C	T&R**	Cu	0202 -1nF – BV30 – T&R 1000pcs, Copper 5μm min		

Table 3 - Packaging and ordering information

(*)AlSiCu



^(**) missing capacitors can reach 0.5%



Pad Metallization

Silicon dies are not sensitive to humidity, please refer to application note 'Products Storage Conditions and Shelf Life'.

Wirebondable component with 2 pads on each terminal.

Pad finishing in Aluminum (3µm thickness), other finishing available on request such as copper, nickel or gold Metallization = Aluminum

Material regulation

This product is RoHS compliant at the time of publication. For further information about regulation compliancy, please ask your sales representative.

Package outline

This MGS Capacitor is delivered as a naked die, with 150 µm opening for contacts.

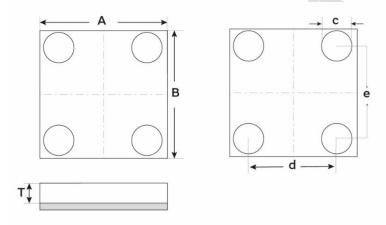


Figure 3 - Package outline drawing

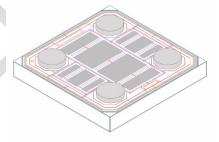


Figure 4 - Package isometric view

A (mm)	B (mm)	T (mm)	c (mm)	d (mm)	e (mm)
0.63 +/- 20µm	0.63 +/- 20µm	0.1 +/- 15µm	0.15	0.293	0.293

Table 4 - Dimensions and tolerances



Assembly

The attachment techniques recommended by Murata on the customer's substrates are fully detailed in specific documents available on our website. To assure the correct use and proper functioning of Murata capacitors please download the assembly instructions on https://www.murata.com/en-us/products/capacitor/siliconcapacitors and read them carefully.



Figure 5 Scan this QR Code to access the Murata Silicon Capacitor web page

Packaging format

Please refer to application note 'Products Storage Conditions and Shelf Life'.

Tape and Reel:

Dies are flipped in the tape cavity (bump down) with die ID located near the driving holes of the tape.

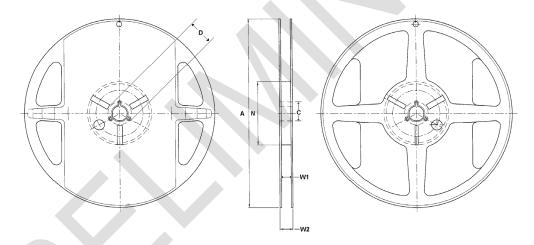


Figure 5 - Reel drawing

Tape Width	Diameter A	С	D	Hub N	W1	W2
8	178 (7 inches)	13.5	20.2	60	9	11.5

Table 5 – Reel dimensions (mm)



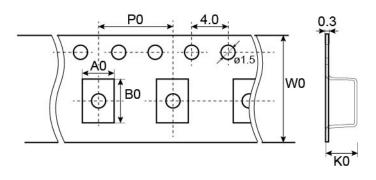


Figure 6 - Tape drawing

Cav	ity dimens	ions	Carrier tape Carrier tap		Quantity	
Ao	Во	Ko	width W0	pitch P0	per reel	
0.76	0.76	0.35	8	4	1000	

Table 6 - Tape dimensions (mm)

Waffle pack:

Please refer to application note 'Waffle Pack Chip Carrier Handling & Opening Procedure'

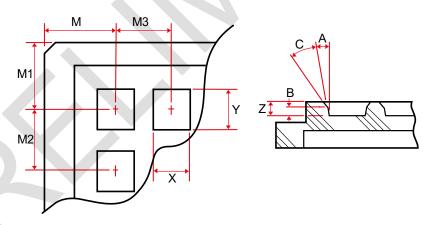


Table 7 - Waffle pack drawing

External dimensions	Max. capacity	Pocket length X	Pocket width Y	Pocket depth Z	
2 inches	20 x 20	0.81	0.81	0.38	

Table 8 - Waffle pack dimensions (mm)



Definitions

Data sheet status

Objective specification: This data sheet contains target or goal specifications for product development.

Preliminary specification: This data sheet contains preliminary data; supplementary data may be published later.

Product specification: This data sheet contains final product specifications.

Limiting values

Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those given in the Electrical performances sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

Revision history

Revision	Date	Description	Author
0.1	6/07/2020	Objective specifications	S. Leruez
2.01	24/11/2020	Template update – Statut update	C. Guezennec

Disclaimer / Life support applications

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